

## **SADC Firmware Developments**

EM

PANDA CM 21/1 - Oliver Noll 10.03.2021





- 1. The Aim of Digital Signal Processing
- 2. Short Summary of Feature Extraction Methods
- 3. Achieved Performance with Beam at MAMI

#### 2. Update of the PANDA SADC Firmware

- 1. Full Free Streaming Data Acquisition
- 2. Request System for Traces and Rates
- 3. Configurable Package Sizing
- 4. Trigger Synchronisation

#### 3. Availability of latest Developments on GitLab

#### **Oliver Noll** EM **The PANDA Backward Calorimeter** Mounting Plate Vacuum Insulation Panels Cover panda **524** lead tungstate crystals Energy range: 10 MeV – 700 MeV Modular design (five types of modules) E HIM Full functional prototype ۲ Helmholtz-Institut Mainz More than 500 hours of experiments at the **Mainz Microtron** ( $e^{-}$ and $\gamma$ ) Development finished **Cooling Shells** Holding Structure ~900 mm Submodule Types:



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#### **Detection Principle – Single-Crystal Unit**



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**Challenge: Compression of Information** 



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# Signal Digitisation and Processing

#### Challenge:



- Self-triggering: pulse identification
- Low detection threshold (< 3 MeV)
- Amplitude extraction (amplitude ∝ energy)
- T<sub>0</sub> extraction (event mapping)
- Pileup detection and correction



#### Field Programmable Gate Arrays (FPGAs):



Firmware for all 64 ADC Channels:

- Self-triggering data acquisition (free streaming)
- Digital filter (sharper bands, stronger attenuation)
- Feature extraction routines
- High event rates (> 100 kHz / channel)
- Slow control (settings, thresholds, requests, ...)

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#### Signal Smoothing via Finite Impulse Response (FIR) Filtering



$$y[n] = \sum_{k=0}^{M} \mathbf{A}_{k} x[n-k]$$

- Finite number of samples for output  $\rightarrow$  no self-excitation
- Precise adoption on pulse shape
- The more filter coefficients (A<sub>k</sub>), the better
- Resource intensive on FPGA
- Implementation via distributed arithmetic and/or DSP slices





#### Identification



- Extraction function
- Highly sensitive on pulse shape
- Improvement of detection efficiency (small energies!)

#### **Detailed explanations:**

- Digital Signal Processing for the Measurement of Particle Properties with the PANDA Electromagnetic Calorimeter, Oliver Noll PhD Thesis
- EMC TDR Update 2021

Digital Signal Processing for APFEL Preamplifier Pulses

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#### Identification



- Extraction function
- Highly sensitive on pulse shape
- Improvement of detection efficiency (small energies!)

#### **Digital Pulse Shaping**

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Pileup detection and correction

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#### Identification



- Highly sensitive on pulse shape
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#### **Digital Pulse Shaping**

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#### Identification



- Highly sensitive on pulse shape
- Improvement of detection . efficiency (small energies!)

#### **Digital Pulse Shaping** Components of Amplitude Extraction

falling

1000

Time

 $H^p_{mrai}$ 

FIR

FIR

Time [ns]

Time

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#### **Detailed explanations:**

Digital Signal Processing for the Measurement of Particle Properties with the PANDA Electromagnetic Calorimeter, Oliver Noll PhD Thesis

50

-50

-200

-250 -300

-350<u></u>∟

isin

ā

500

Derivation  $\rightarrow$  Inf

Built-in baseline

Elimination of fa

**Pileup detection** 

Amplitude -150

EMC TDR Update 2021

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#### **Oliver Noll Digital Zero Cross Interpolation for TO-Determination**



$$T_0 = i_0 + \frac{D'[i_0]}{D'[i_0] - D'[i_1]}$$

$$D' \text{ is second derivative,}$$
since *D* is the first one

- Fragmentation of time between samples: **12.5 ns / 64 = 195 ps**
- Precision is a function of scaling
- Impact on FPGA resources

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As always: good compromise between FPGA resources and precision

## **TO-Determination: Pulse Transportation along Time Axis**

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Digital Signal Processing for APFEL Preamplifier Pulses

A (G)H

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## **TO-Determination: Pulse Transportation along Time Axis**



**Oliver Noll** 



$$T_0 = i_0 + \frac{D'[i_0]}{D'[i_0] - D'[i_1]}$$

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- Technical precision limitation
- Can be improved if necessary
  - Impact on other parts of the implementation
  - Larger word widths
  - More cycles at the division

Digital Signal Processing for APFEL Preamplifier Pulses





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Example: APD gain 200:

TR(60 MeV) = 1.517(10) ns TR(500 MeV) = 182(1) ps



#### Test Measurements at the Mainz Microtron MAMI



- Energy stability: 13 keV (1σ)
- Beam spot width: ~1mm

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#### Prototype Tests at the Mainz Microtron MAMI

# **Oliver Noll**

## **Energy Calibration and Sum Spectra**



- Differences in single-crystal unit responses
- Geant4 simulation: Expected deposited energy
- Energy calibration  $\rightarrow$  normalisation



- APD Gain: 150, threshold: 2.5 MeV
- Position  $\propto E$ , Width  $\propto \sigma_F \rightarrow \sigma_F/E$

Prototype Tests at the Mainz Microtron MAMI



3x3 Sum Spectra

#### Cliver Noll The Relative Energy Resolution



- Most important characterisation of a calorimeter
- Distinguishability of nearby energies

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Constant Stochastic Noise

#### Technical Design Report (TDR) requirements:

 $a_{\text{TDR}} \leq 1\%$   $\checkmark$ 

• 
$$b_{\text{TDR}} \leq 2 \frac{\%}{\sqrt{\text{GeV}}} \checkmark$$

- $c_{\text{TDR}} \leq 3 \text{ MeV} \checkmark$
- $\sigma_E/E(1 \text{ GeV})_{\text{TDR}} \le 2.5\%$

## The Detector Response as a Function of the Deposited Energy



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Leakage energies considered by Geant4 simulation

Nonlinearity ~ 1 MeV, O(‰)





## High-Rate Measurements (PANDA Rate $\sim 100 \text{ kHz} + R_{\text{NHR}}$ )





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#### $P_{\rm 100kHz}:$ Pileup probability at 100 kHz

Dead time $ au$	P <sub>100kHz</sub>	P <sub>100kHz</sub>	P <sub>100kHz</sub>
	uncorrected	corrected	TDR
464(13) ns	13.9 %	4.53(12) %	1 %

- Pileup detection on FPGA and pileup correction on CPU
- Reduction of effective pileup
   probability



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IGUY

Prototype Tests at the Mainz Microtron MAMI

## Latest Firmware Developments for the PANDA SADC



• SADC v 2.0

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- Modification of "Bonn Firmware" Kindly supported by Johannes Müllers
- First self-triggering DAQ implementation in 2018
- Successfully tested with beam



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- SADC v 3.5
- Final SADC for PANDA
- Also used for FAIR Phase-0 in Mainz
- Update and restructuring of firmware
  - Full free streaming approach
  - Request system for traces and rates

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Configurable package sizing



## Latest Firmware Developments: New Hierarchy



Firmware Developments for the PANDA SADC



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Firmware Developments for the PANDA SADC

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#### Latest Firmware Developments: High-Rate Capability



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#### Latest Firmware Developments: High-Rate Capability



• Noise hits: 100 kHz / channel (very conservative)



## Latest Firmware Developments: Free Streaming Mixed Readout

Time



#### Simulation: 200 kHz Hit Rate per Channel

Signals	Waves
Time	0 100 us
i clk 80=1	
i clk 125=0	
i reset 125=0	
o ready fe=0	
i request ra=0	
cnt flag=0	
cc[7:0]=0	o Mole I Mo To I To Io Mo To Io Io Jolio Mo
amp[15:0]=0000	ecce ])+ ]e+ ), <u>∏</u> eece ]e+  , ≬e+  , ∮e+  , ∮eece ]]ecce  , ∮eece  , ↓ecce ], ↓ecce ], ↓ecce ]+ ), ]+ ]], ↓e+ ]]eece
ts[39:0]=000000000	00000000000)/+ ]e+ // <b>1</b> 0000000+]e+ // /0000000+]e0e+ //0000000+ /+ //00000+ // (0000+ //+/// 1+///00+///0000000000000000
hit cnt meas[13:0] =896	0 X+ )96 X 224 X+ (3+ )352 X 416 448 + )512 576 688 X+ (4 896
hit cnt theo[13:0] =896	0 //64/96 /+%/224 /2+/+/320/352 //416 /448 /4+/512 //576 /608 /+/()+1/832)/896
ss data valid=0	
ed packet data[7:0]=00	C 00 00 00 00
ed tvalid=0	
ed tlast=0	
-	

- 200 kHz / channel ٠
- Free streaming mixed readout ۲
  - Different data frames appear to arbitrary times
  - Request system
- Rate request (one small package)
- Sample request (64 samples / channel) •
- Still, plenty of headroom



## Latest Firmware Developments: Free Streaming Mixed Readout

#### **SADC** Data Logic



### Simulation: 200 kHz Hit Rate per Channel

2																		100	) us					
																					$\leq$			
θ		10		0	1	3 1	Ð	0	10	0	10	0	0	10	0	0	.0	.0						
0000	11+	10+	1	0000	1	9 <b>4</b> 1	10+	0000	10000	10000	14	0000	10000	9 9999 6	15	17	1.0+	166	00			-		
00000000000	11+	0+	ñ	00000	IØ+16	9 <b>4</b> 1	<b>θ</b> +	00000000	1000+	10000000	1.	00000+	1000	0000+	17	17	0+	100	00000000					
0		196	Ň	274	- î	28	13+	352	1416	448	1.0	1512	576	688	10		18+	89	16					
θ.	64	96		224	-6	1	276	252	Ante	1449	Ča.	1512	Were	Vcoe	viv	1.1	027	leas						
	-				-																			
8 80	÷									-								-						
	-				_	-		_									_			_				_

- 200 kHz / channel
- Rate request (one small package)
- Sample request (512 samples / channel)
- More FIFO depth, more resources... not necessary
- Configurable package sizing:
  - Long traces for detector adjustments (>512 samples)
  - Shorter traces for pileup events (≈128 samples)
  - Very short trace for monitoring (≈64 samples)

i\_clk\_80=1 i\_clk\_125=0 i\_reset\_125=0 o\_ready\_fe=0 i\_request\_ra=0 cnt\_flag=0 cc[7:0]=0 amp[15:0]=000

ts[39:0]=00000 hit\_cnt\_meas[13:0]=896 hit\_cnt\_theo[13:0]=896

ss\_data\_valid=0 packet\_data[7:0]=3E ed\_tvalid=1 ed\_tlast=0



#### Latest Firmware Developments: Pileup



• Feature extraction is capable to distinguish pulses

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• Software amplitude recovery





#### Latest Firmware Developments: Pileup



• Feature extraction is not anymore capable to distinguish pulses

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- Activation of sample sender for specific channel
- More sophisticated recovery on CPU





Arbitrary total trace length





#### Latest Firmware Developments: Availability of Source



https://gitlab.rlp.net/emp/sadc\_data\_logic

https://gitlab.rlp.net/emp/sadc\_v\_3\_5

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## Summary and Next Steps

#### **Summary**

- Digital signal processing optimised for APFEL preamplifier signals
- Successfully tested with beam
- SADC firmware which supports trigger-less readout concept of PANDA
- Firmware Update:
   SADC v. 2.0 → SADC v. 3.5
  - Restructuring of hierarchy
  - Full free streaming concept
  - Request system (traces, rates)
  - Configurable package sizing
  - Trigger synchronisation
- Source is available



## Summary and Next Steps

#### **Summary**

- Digital signal processing optimised for APFEL preamplifier signals
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  - Restructuring of hierarchy
  - Full free streaming concept
  - Request system (traces, rates)
  - Configurable package sizing
  - Trigger synchronisation
- Source is available

#### Next Steps

- Current firmware will be used for
  - detector component tests
- Submodule calibration (FAIR Phase-0)



Preparations for Phase-0 and PANDA





# **Digital Signal Processing**

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Configurable Logic Blocks

#### Why so "fast"?

- Infrastructure adapted on problem
- True parallelism



Programmable Switch Matrix



#### **Efficient Implementation on FPGA**



Implemented on FPGA:  $M = 19, k \in [0, 1, ..., 19]$ 

#### Lookup Table (LUT)

Possible result	Binary signature	Value
1	000	$A_0 \cdot 0 + A_1 \cdot 0 + A_2 \cdot 0 = V_0$
2	001	$A_0 \cdot 0 + A_1 \cdot 0 + A_2 \cdot 1 = V_1$
3	010	$A_0 \cdot 0 + A_1 \cdot 1 + A_2 \cdot 0 = V_2$
4	011	$A_0 \cdot 0 + A_1 \cdot 1 + A_2 \cdot 1 = V_3$
5	100	$A_0 \cdot 1 + A_1 \cdot 0 + A_2 \cdot 0 = V_4$
6	101	$A_0 \cdot 1 + A_1 \cdot 0 + A_2 \cdot 1 = V_5$
7	110	$A_0 \cdot 1 + A_1 \cdot 1 + A_2 \cdot 0 = V_6$
8	111	$A_0 \cdot 1 + A_1 \cdot 1 + A_2 \cdot 1 = V_7$

Example:  $M = 2, k \in [0,1,2], 2^{M+1} = 8$ 

$r_0$ (				-	4	4
~0 0	1	 1	1	0	0	0
$x_1 = 0$	0	 1	1	1	1	1
$x_2$ 0	1	 0	1	0	0	1
output $V$	$V_5$	 $V_6$	$V_7$	$V_2$	$V_2$	$V_3$

- Only sums and bit shift operations
- Avoiding limited multiplication networks
- High order (20 coefficients) filter for all channels

#### Gliver Noll Hit Detection



$$\lambda(i_t) = \begin{cases} e^{A_t \cdot i_t} &: i_t \le P_t \\ M_t \cdot e^{-A_t(i_t - P_t)} &: i_t > P_t \end{cases}$$



- Sensetive on pulse shape
- Ingrease of detection efficiency



#### **Amplitude Extraction**



**TMAX Pileup Detection** 

- Derivation  $\rightarrow$  Integration
- Build in baseline follower
- Elimination of falling edge
- Pileup detection and correction

Oliver Noll Time  $(T_0)$  Extraction





# Measurements

## Sum Contribution 3x3, 855 MeV

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## **Threshold Scan and Dual Gain Readout**

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#### **Pileup Detection and Correction**



Type	$\Delta T$	k	$\lambda = \Delta T \cdot 100 \mathrm{kHz}$	$P_{100\mathrm{kHz}}$
1	$\geq 1500  \mathrm{ns}$	0	0.150	86.1%
2	$\leq 450\mathrm{ns}$	1	0.045	4.3%
3	$\geq 450 \mathrm{ns} \wedge \leq 1500 \mathrm{ns}$	1	0.105	9.5%
4	$\leq 1500  \mathrm{ns}$	$\geq 2$	0.150	1.0%

Event Types at a Detector Rate of 110.35 kHz





10<sup>2</sup>

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#### **Pileup Detection and Correction**

$$H_{\text{corr.}}^s = H_{\text{meas.}}^s \cdot \Sigma(H_{\text{meas.}}^p, H_{\text{meas.}}^s, \Delta t)$$



- Type 3 events (second pulse within falling edge of first pulse) are correctable
- Monochromatic electron beam
- Proof of principle
- To do: Map out  $\Sigma$  with simulations

stuna Vonuts OO Type 3 uncorrected Туре З Type 3 corrected 40000 Type 1 35000 Type 1 + Type 3 corr. 30000 25000 **Measurement** 20000 15000 10000 5000 500 1000 1500 2000 2500 3000 3500 Amplitude [a.u.]

#### Impact of Type 3 Correction



## Beam Test with the EMC Prototype : Results

Parameter	Achie		TDR	Unit	
	Worst	Typical	Best		
Rel. En. Res.					
$\sigma_E/E$ at 1 GeV	2.440(14)	2.207(6)	2.190(2)	$\leq 2.5$	%
Constant $a$	1.23(21)	1.08(14)	0.95(61)	$\leq 1$	%
Statistics $b$	2.02(65)	1.83(45)	1.78(30)	$\leq 2$	$\frac{\%}{\sqrt{E[\text{GeV}]}}$
Noise/Ch. $c$	2.14(9)	2.02(15)	1.92(60)	$\leq 3$	${\rm MeV}$
Non-Linearity					
Maximum	2.22(36)	1.26(24)	1.21(19)	-	%0
Timing					
Dead Time $\tau$	-	464(13)	-	-	ns
Pileup $P_{100  \rm kHz}$	$13.9 (\mathrm{w/o \ corr.})$	4.53(12)	-	1	%
Highest Event Rate	-	-	375.4(6)	100	kHz



# Simulations

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## Simulations for the Study of Digital Signal Processing Methods

Defined testing environment

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- Realistic detector signals (pulse shape + noise)
- Optimisation of filter parameters
- Performance tests: detection efficiency, noise hit rate, linearity, time resolution, ...





- Noise hit rate (R<sub>NHR</sub>)
- Detection efficiency ( $\eta$ ) for 3 MeV events



#### **Generation of Realistic Detector Signals**



$$\alpha = \frac{q}{M \cdot LY_{-25^{\circ}C} \cdot A_{eff} \cdot Q_{eff} \cdot e \cdot G_{ASIC}}$$
[MeV/channel]

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Parameter	Value	Unit	Source
q	0.122	mV/channel	[Cor18]
M	$\geq 1$	-	-
$LY_{-25 \circ C}$	500	$n_{\rm photo.}/{\rm MeV}$	[TDR08]
$A_{\rm eff.}$	16	%	[HAM09]
$Q_{\rm eff.}$	0.70	$n_{\rm elec.}/n_{\rm photo.}$	[HAM09]
e	$1.602176634 \times 10^{-19}$	С	[NT19a]
$G_{\rm ASIC}$	$0.22 \times 10^{15}$	$\rm mV  C^{-1}$	[Wie19]

 $H = \frac{E \,[\text{MeV}]}{\alpha(M) \,[\text{MeV/channel}]} \,[\text{channel}]$ 

 $A = E[\text{MeV}] \cdot \alpha(M)^{-1} \cdot e^N$ 

## **Generation of Realistic Detector Signals**



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$$C(I_i) = \cos_{I_i}(x + \phi) \cdot 10^{\frac{P(I_i)[dB}{20}}$$

$$T_{\text{noise}} = \sum_{i=1}^{N_{-}I} C(I_i)$$



## **Comparison between Simulation and Measurement**



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## **Comparison between Simulation and Measurement**

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#### Performance Tests with the Simulation Framework



• Generate trace for low gain and high gain

- Defined pulse appearance times
- Noise hit region
- Vary amplitudes (energies) and thresholds

## Performance Tests with the Simulation Framework: Noise Hit Rate



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DAQ Limit = 558 kHz – 100 kHz (true events)

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## Performance Tests with the Simulation Framework: Noise Hit Rate



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Example Threshold = 1.0 MeV Efficiency = 80.7 % (3 MeV events) NHR = 6.8 kHz

## Performance Tests with the Simulation Framework: Time Resolution



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Example: APD gain 200:

TR(60 MeV) = 1.517(10) ns TR(500 MeV) = 182(1) ps

## Performance Tests with the Simulation Framework: Linearity



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Amplitude Distribution at 100 MeV and APD Gain 200

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#### Example: APD gain 200:

Always smaller than **160 keV** Above 100 MeV smaller than **50 keV** Single crystal threshold: **3 MeV** 



## Performance Tests with the Simulation Framework: Results

Parameter			Achieved	TDR	Unit				
APD Gain	1	50	20	0	2	-	-		
Preamp. Gain	LG	HG	LG	HG	LG	HG	-	-	
Noise Hit Rate	Threshold: 2.5 MeV								
Single	331.1(26)	160.9(20)	151.44(200)	38.07(110)	67.93(145)	5.52(45)	-	kHz	
Dual $(I_{\rm comp.} = 200  \rm ns)$	1.27(5)	0.16(1)	0.13(1)	$<\!0.01$	$<\!0.1$	< 0.01	-	$\mathrm{kHz}$	
Efficiency	Deposited Energy: 3 MeV								
Threshold: 2.5 MeV	39.6	50.4	41.3	55.3	42.4	58.5	-	%	
Threshold: 1.5 MeV	55.9	65.9	57.1	76.6	61.5	83.9	-	%	
Time Resolution									
$60{ m MeV}$	5.369(35)	1.998(13)	4.051(26)	1.517(10)	3.176(21)	1.198(8)	1	ns	
$500{ m MeV}$	635(4)	239(2)	477(3)	182(1)	380(2)	144(1)	150	$\mathbf{ps}$	
Non-Linearity	Upper Limit								
Dep. Energies $< 100 \mathrm{MeV}$	635.12(23)	288.24(179)	138.24(70)	134.80(7)	162.17(7)	103.66(73)	-	$\rm keV$	
Dep. Energies $\geq 100 \mathrm{MeV}$	64.81(3)	41.31(27)	44.90(3)	21.62(27)	44.78(3)	21.05(26)	-	$\rm keV$	

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Table 5.3: The table summarises the results of the parameter extraction performance simulation.





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## **Exploratory Measurements and Simulations for FAIR Phase-0**



- Determination of  $\pi^0 \gamma \gamma$  transition form factor  $\rightarrow$  hadronic light-by-light contribution to  $g_{\mu} - 2$
- Version of PANDA backward calorimeter
- Electron scattering at heavy nucleus (Tantalum, Z=73)
- Measurement in forward direction

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- Strong low energy electromagnetic background
- Relative energy resolution at small scattering angles?



## Signal Generator for Low Energetic Background



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- High rates
- ...

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## Relative Energy Resolution (3x3) as a Function of the Luminosity





\*Measurement of the Electromagnetic Transition Form Factor of the  $\pi^0$  in the Space-Like Region via Primakoff Electroproduction. Letter of Intent, 2020

## The Anomalous Magnetic Moment of the Muon

#### Dirac Theory:

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Dirac equation with EM-field:  

$$\begin{aligned}
(i\gamma^{\mu}\partial_{\mu} - e\gamma^{\mu}A_{\mu} - m)\psi &= 0\\
\text{Nonrelativistic limit } (E \approx m):\\
\frac{1}{2m} |\vec{p} - e\vec{A}|^{2}\psi - \frac{e}{m}\vec{S}\cdot\vec{B}\psi &= 0\\
& \mu_{s}\\
g &= \frac{\mu_{s}}{\mu_{L}} = 2 \qquad a_{l} = \frac{g_{l} - 2}{2} = 0
\end{aligned}$$



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#### Messung:

$$\omega_{L} = \frac{g}{2} \cdot \frac{eB}{m} \qquad \omega_{c} = \frac{eB}{m}$$

$$a_{\mu}^{\text{Exp.}} = 0.00116592089(63)$$
BNL (E821) 2006

$$\begin{array}{c} a_{\mu}^{\rm SM} = 0.00116591782(43) \\ a_{\mu}^{\rm Exp.} = 0.00116592089(63) \end{array} \right\} 4\sigma$$

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## Reduction of the Uncertainty on $a_{\mu}^{SM}$ by a Data-Driven Approach

#### Hadronic Light-by-Light Scattering



#### Primakoff $\pi^0$ Electroproduction



# A(N,Z)

- Full developed FAIR detectors in standalone experiments
- PANDA backward calorimeter for FAIR Phase-0 at MAMI

Data-Driven Approach





## The Primakoff $\pi^0$ Electroproduction

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Measurement of the Electromagnetic Transition Form Factor of the  $\pi^0$  in the Space-Like Region via Primakoff Electroproduction. Letter of Intent, 2020

EΜ



## The Primakoff $\pi^0$ Electroproduction





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#### FAIR Phase-0 Test Beam at MAMI



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- Polyethene  $[-CH_2 CH_2]_n \rightarrow elastic electron proton scattering on H nuclei$ 
  - Coincidence with spectrometer A (proton) and prototype (electron)
  - Energy calibration
- Quasi-elastic scattering on <sup>12</sup><sub>6</sub>C
- Rate and background determination on <sup>181</sup><sub>73</sub>Ta
- Electron tagger test (electron-photon separation)

#### FAIR Phase-0 Test Beam: Background



#### Signal Generator:

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- 1. Number of hits on trace by Poisson random generator:  $R(I_{Beam}) = \frac{R_{100nA}}{100 nA} \cdot I_{Beam}$
- 2. Time of occurrence by uniform random generator
- 3. Energy amplitudes via background energy distribution by using a uniform random generator (0,1)